## Notice of References Cited Application/Control No. 10/606,788 Examiner Devin Almeida Applicant(s)/Patent Under Reexamination SAKURAI ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0002671	01-2003	Inchalik et al.	380/202
*	В	US-2002/0100052	07-2002	Daniels, John J.	725/87
*	С	US-6,029,259	02-2000	Sollish et al.	714/719
*	D	US-2001/0018743	08-2001	Morishita, Takuya	713/193
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			•

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
1	Т					

## **NON-PATENT DOCUMENTS**

_	NON-PATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	V						
	w						
	x						

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.